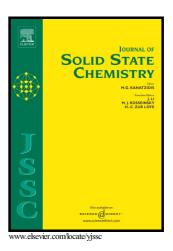
## Author's Accepted Manuscript

Control of Mg content and carrier concentration via post annealing under different Mg partial pressures for Sb-doped Mg<sub>2</sub>Si thermoelectric material

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## ACCEPTED MANUSCRIPT

Control of Mg content and carrier concentration via post annealing under different Mg

partial pressures for Sb-doped Mg<sub>2</sub>Si thermoelectric material

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Abstract

An approach to control the Mg content in Sb-doped Mg<sub>2</sub>Si via post annealing under different

Mg partial pressures is developed. Annealing under low and high Mg partial pressures ( $\leq 1 \times 10^{-1}$  Pa

and 1×10<sup>1</sup> Pa) result in low and high carrier concentrations of Mg<sub>2</sub>Si<sub>0.99</sub>Sb<sub>0.01</sub> (1.2×10<sup>20</sup> cm<sup>-3</sup> and

1.7×10<sup>20</sup> cm<sup>-3</sup>) that correspond to a hypo-stoichiometric and a hyper-stoichiometric compositions,

respectively. Mg<sub>2</sub>Si<sub>0.99</sub>Sb<sub>0.01</sub> with a hypo-stoichiometric composition shows a low figure of merit

below 573 K mainly due to a reduction of the carrier mobility probably by the carrier scattering at

Mg-deficient grain boundaries. The carrier mobility and the figure of merit are recovered by

increasing the Mg content via annealing under high Mg partial pressure, which indicates that the

annealing process is an effective way to recover the thermoelectric performance of Mg-deficient

Mg<sub>2</sub>Si-based materials.

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